A Sequential Importance Sampling for Estimating the Multi-Period Market Risk

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Objective

- We propose a sequential importance sampling for estimating the multi-period market risk.
- We compare the performance of proposed method to that of the crude Monte Carlo simulation.

Backgrounds

Definitions & Notations

- Let P_t , t = 1, 2, ..., be the price of a portfolio at the end of the t-th time period.
- Let $R_t = \log(P_t/P_{t-1})$ be the single period log return and $\Phi_t = \{R_t, R_{t-1}, \dots, R_1\}$.
- The log return of the portfolio over k time periods is represented as $R_t(k) = \sum_{i=0}^{k-1} R_{t+i}$.
- The value-at-risk of the portfolio over k periods with confidence level q is defined as

$$VaR_t^q(k)$$
 = the q-quantile of $-R_t(k)$ given Φ_{t-1} .

• The expected shortfall of the portfolio over k periods with confidence level q is defined as

$$ES_t^q(k) = -E[R_t(k)|R_t(k) \le -VaR_t^q(k)]. \tag{2}$$

GJR-GARCH Model

- Let $\sigma_t^2 = V[R_t | \Phi_{t-1}]$ be the conditional volatility of R_t .
- In GJR-GARCH(p, q) model,

$$\sigma_t^2 = \omega + \sum_{i=1}^q (\alpha_i + \gamma_i I_{t-i}) R_{t-i}^2 + \sum_{i=1}^p \beta_i \sigma_{t-i}^2,$$

$$R_t = \sigma_t z_t, \ z_t \stackrel{i.i.d.}{\sim} \pi(z),$$

where $\pi(z)$ is a pdf with mean 0 and variance 1, and I_t is the indicator function such that

$$I_t = \begin{cases} 1, & ext{if } R_t < 0, \\ 0, & ext{if } R_t \geq 0. \end{cases}$$

• $\theta = (\omega, \alpha_1, \dots, \alpha_p, \beta_1, \dots, \beta_q)$ is estimated by fitting model (3) to Φ_t ; denote it by $\hat{\theta}_t$.

Crude Monte Carlo simulation

• We define $H_t = \{(\sigma_t^2, R_t), (\sigma_{t-1}^2, R_{t-1}), \ldots\}$, and rewrite equation (3) as

$$\sigma_t^2 = \psi(H_{t-1}; \theta), \quad t = 1, 2, \dots$$
 (4)

- Let $\tilde{\pi}_{t-1}(z)$ be the approximate distribution of $\pi(z)$ given Φ_{t-1} .
- Let $\{\tilde{Z}_t, \tilde{Z}_{t-1}, \dots, \tilde{Z}_{t+k-1}\}$ be random samlpes from $\tilde{\pi}_{t-1}(z)$: for $i = 0, 1, \dots, k-1$, we generate

$$ilde{\sigma}_{t+i}^2 = \psi(\tilde{H}_{t+i-1}; \hat{ heta}_{t-1}), \ ilde{R}_{t+i} = ilde{\sigma}_{t+i} ilde{Z}_{t+i},$$

• A simulated log return over *k* periods from period *t* is as follows:

$$\tilde{R}_t(k) = \sum_{i=0}^{k-1} \tilde{R}_{t+i}.$$
 (6)

- Repeating the above procedure N times independently, we obtain $\tilde{R}_t^{(1)}(k), \ldots, \tilde{R}_t^{(N)}(k)$.
- $\widehat{\text{VaR}}_{t}^{q}(k)$ is estimated as the 100q-th percentile of the negated log returns over k days, i.e.

$$\widehat{\text{VaR}}_{t}^{q}(k) = \text{Percentile}(\{-\tilde{R}_{t}^{(1)}(k), \dots, -\tilde{R}_{t}^{(N)}(k)\}, 100q), \tag{7}$$

and that

$$\widehat{\mathrm{ES}}_{t}^{q}(k) = -\frac{\sum_{j=1}^{N} I(\widetilde{R}_{t}^{(j)}(k) \leq \widehat{\mathrm{VaR}}_{t}^{q}(k)) \widetilde{R}_{t}^{(j)}(k)}{\sum_{j=1}^{N} I(\widetilde{R}_{t}^{(j)}(k) \leq \widehat{\mathrm{VaR}}_{t}^{q}(k))}.$$
(8)

Proposed scheme

Sequential Importance Sampling

- Suppose that residuals $\{\hat{Z}_{t-i} = R_{t-i}/\hat{\sigma}_{t-i}, i = 1, 2, ..., m\}$ are obtained at the end of period t-1 for a sufficiently large m.
- We trim the residuals: if the absolute value of a residual is larger than 4, then it is replaced by 4 or -4.
- We approximate $\pi(z)$ by $\pi_{t-1}(z) = \frac{1}{m} \sum_{j=1}^{m} \phi_{\delta}(z \hat{Z}_{t-j})$, where $\phi_{\delta}(z)$ is the pdf of $N(0, \delta^2)$.
- We define the importance sampling pdf of \tilde{Z}_{t+i} for $i=0,\ldots,k-1$ as follows: for $\lambda\in(-\infty,\infty)$,

$$g_{t-1}(z;\lambda) \propto \exp\{\lambda z\} \pi_{t-1}(z), \quad -\infty < z < \infty.$$
 (9)

- We generate *N* processes of $\{\tilde{Z}_{t}^{(j)}, \tilde{Z}_{t-1}^{(j)}, \dots, \tilde{Z}_{t+k-1}^{(j)}\}$ from $g_{t-1}(z; \lambda), j = 1, \dots, N$.
- Applying equation (5), we obtain $\tilde{R}_{t:(t+k-1)}^{(j)}$, the log return process corresponding to $\tilde{Z}_{t:(t+k-1)}^{(j)}$.
- The unnormalized likelihood ratio of $\tilde{R}_{t:(t+k-1)}^{(j)}$ with respect to $\pi_{t-1}(z)$ is given by

$$w^{(j)} = \exp\left\{-\lambda \sum_{i=0}^{k-1} \tilde{Z}_{t+i}^{(j)}\right\}, \quad j = 1, \dots, N.$$
 (10)

• Let $\tilde{R}_t^{(j)}(k)$ be the k-period log return corresponding to $\tilde{R}_{t:(t+k-1)}^{(j)}$. If we let $W^{(j)} = w^{(j)} / \sum_{j=1}^{N} w^{(j)}$, then we have that

$$\widehat{\Pr}_{\pi_{t-1}}\{\widetilde{R}_t(k) \le x\} = \sum_{j=1}^N I(\widetilde{R}_t^{(j)}(k) \le x) W^{(j)} = \sum_{j=1}^N I(r_j \le x) W_j,$$
(11)

where $\{r_1, \ldots, r_k\}$ be the order statistic of $\{\tilde{R}_{t:(t+k-1)}^{(1)}, \ldots, \tilde{R}_{t:(t+k-1)}^{(N)}\}$ and W_j be the likelihood ratio corresponding to r_j .

• We define $j^* = \max\{J : \sum_{j=1}^J W_j \le 1 - q\}$. It follows from equation (11) that

$$\widehat{\text{VaR}}_{t}^{q}(k) = -\frac{r_{j^{*}} + r_{j^{*}+1}}{2}, \ \widehat{\text{ES}}_{t}^{q}(k) = -\frac{\sum_{i=1}^{j^{*}} r_{i} W_{i}}{\sum_{i=1}^{j^{*}} W_{i}}.$$
(12)

The optimal twisting parameter

• Given H_{t-1} and θ , $R_{t:(t+k-1)}$ is determined by $Z_{t:(t+k-1)}$. i.e. for a function $r(\mathbf{z}), \mathbf{z} \in \mathbb{R}^k$,

$$R_t(k) = r(Z_{t:(t+k-1)}; H_{t-1}, \theta).$$
 (13)

- The joint pdf of $Z_{t:(t+k-1)}$ is denoted by $\pi(z) = \prod_{i=1}^k \pi(z_i)$ for $\mathbf{z} \in \mathbb{R}^k$.
- Since $r(Z_{t:(t+k-1)}; H_{t-1}, \theta)$ is less than $-VaR_t^q(k)$ with probability p, equation (2) says that

$$\mathsf{ES}_t^q(k) = E_{\pi} \left[\tau_t(Z_{t:(t+k-1)}) \right], \tag{14}$$

where

(1)

(3)

$$\tau_t(z) = \frac{-r(z; H_{t-1}, \theta) I(r(\mathbf{z}; H_{t-1}, \theta) \leq -\mathsf{VaR}_t^q(k))}{p}, \quad \mathbf{z} \in \mathbb{R}^k.$$

• Since $\tau_t(Z_{t:(t+k-1)})$ is nonnegative almost surely, the optimal importance sampling pdf of $Z_{t:(t+k-1)}$ for the estimation of the k period expected shortfall is as follows:

$$g^*(z; H_{t-1}, \theta, \mathsf{VaR}_t^q(k)) = \frac{\tau_t(\mathbf{z})\pi(\mathbf{z})}{\mathsf{ES}_t^q(k)}, \quad \mathbf{z} \in \mathbb{R}^k.$$
 (15)

• In the proposed sequential importance sampling, the pdf of an importance sample z is

$$g_{t-1}(\mathbf{z};\lambda) = \prod_{i=1}^{K} g_{t-1}(z_i;\lambda), \quad \mathbf{z} \in \mathbb{R}^{k}.$$
 (16)

• We want to determine the value of the twisting parameter λ so that the cross entropy of $g_{t-1}(\mathbf{z};\lambda)$ relative to $g^*(\mathbf{z};H_{t-1},\theta)$ is minimized. Then, the desired value of λ is given by

$$\lambda^* = \operatorname{argmin} E_{g^*} \left[\log \frac{g^*(\mathbf{Z}; H_{t-1}, \theta, \operatorname{VaR}_t^q(k))}{g_{t-1}(\mathbf{Z}; \lambda)} \right] = \operatorname{argmax} E_{\pi}[\tau_t(\mathbf{Z}) \log g_{t-1}(\mathbf{Z}; \lambda)]. \tag{17}$$

Finding the optimal twisting parameter

- The approximate value of λ^* can be found by the stochastic approximation.
- Let $\mathbf{Z}^{(1)},\ldots,\mathbf{Z}^{(L)}\overset{i.i.d.}{\sim}\pi_{t-1}(\mathbf{z})$. Then,

$$E_{\pi}[\tau_t(\mathbf{Z}) \log g_{t-1}(\mathbf{Z}; \lambda)] \approx \frac{1}{L} \sum_{l=1}^{L} \tau_t(\mathbf{Z}^{(l)}) \log g_{t-1}(\mathbf{Z}^{(l)}; \lambda).$$
 (18)

• For $R^{(L)} = r(z^{(I)}; H_{t-1}, \widehat{\theta}_{t-1})$, we let $S = \{I : R^{(I)} \le -\text{VaR}_t^q(k)\}$. The above equation is rewritten as

$$E_{\pi}[\tau_t(\mathbf{Z})\log g_{t-1}(\mathbf{Z};\lambda)] \approx -\frac{1}{pL} \sum_{l \in S} R^{(l)} \log g_{t-1}(\mathbf{Z}^{(l)};\lambda).$$
 (19)

• Maximizing the above equation gives the pseudo-optimal vaule of λ^* .

Numerical Results

Simulation for 10 days 99% VaR

- The data contain the S&P 500 Index for the 13365 days from January 4, 1971 to December 29, 2023 with a window size of 750 days.
- At each 10th days we simulate the stochastic process of daily log returns over next 10 days using the fitted GJR-GARCH(1,1) model.
- In crude Monte Carlo (CMC), $\pi(t)$ is approximated by the standardized Student t:

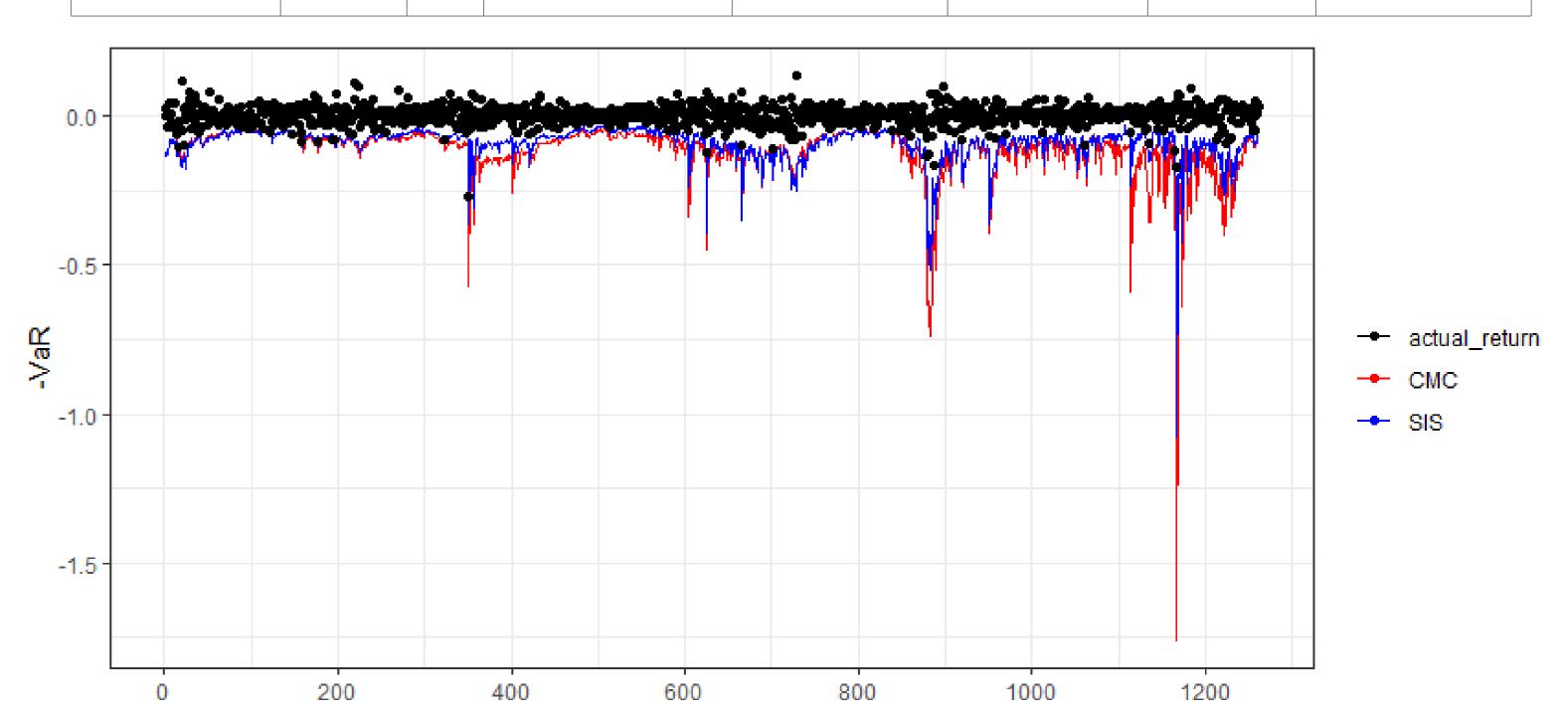
$$R_t = \sigma_t Z_t, \quad Z_t \stackrel{i.i.d.}{\sim} \text{Standardized Student t},$$
 (20)

- We use parallel processing in CMC and SIS.
- To estimate the standard error, we use a naive method.

Simulation Results

• The result for the described simulation is given in the following table and figure.

Risk measure	Method	δ	confidence level	standard error	relative error	Time(sec.)	excessive loss
VaR	CMC	0.25	0.99	0.00329	0.02574	613.8214	9
	SIS			0.00262	0.02842	476.9906	13
ES	CMC	0.25	0.99	0.00685	0.03518	616.3564	
LS	SIS			0.00287	0.02319	486.1364	



Conclusion

- Our proposed estimator takes much less time than the CMC and shows the standard errors lower than the CMC.
- Our proposed method is more efficient than CMC.